

MAR92A

This item can replace **BFR92A**



Approved by:
Checked by:
Issued by:

SPECIFICATION

PRODUCT: NPN 5GHz wideband transistor

MODEL: MAR92A SOT23

H.K.HUIYEE ELECTRON INDUSTRIAL LIMITED

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FEATURES

- High power gain, Insertion power gain $|S_{21}|^2=14\text{dB}$ at 1GHz
- Low noise, Noise figure $NF=2.1\text{dB}$ at 1GHz
- High transition frequency $f_T=5\text{GHz}$
- Gold metallization ensures excellent reliability
- Large dynamic range
- Good current characteristic
- SOT-23 / SC-59 package

MARKING:2D

APPLICATION

Intended for applications in the GHz range such as MATV or CATV amplifiers and RF communications subscriber equipment.

DESCRIPTION

NPN silicon planar transistor 3 pin SOT-23 package.

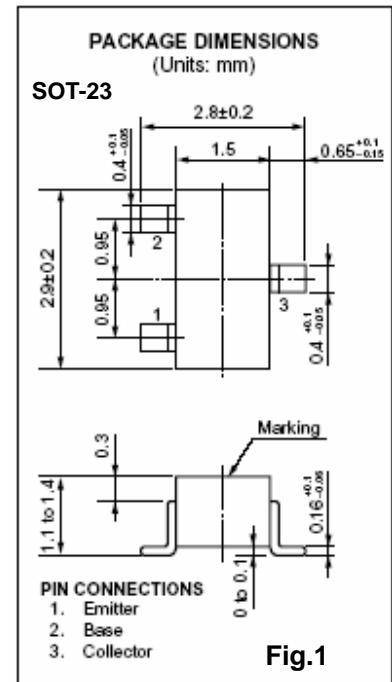


Fig.1

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
V_{CBO}	collector-base voltage	open emitter		20	V
V_{CEO}	collector-emitter voltage	open base		15	V
I_C	collector current (DC)			25	mA
P_{tot}	total power dissipation	$T_s \leq 95^\circ\text{C}$	300		mW
C_{re}	Feedback capacitance	$I_C=0$; $V_{CE}=10\text{V}$; $f=1\text{MHz}$	0.35	-	pF
f_T	Transition frequency	$I_C=15\text{mA}$; $V_{CE}=10\text{V}$; $f=500\text{MHz}$	5	-	GHz
G_{UM}	maximum unilateral power gain	$I_C=15\text{mA}$; $V_{CE}=10\text{V}$; $f=1\text{GHz}$; $T_{amb}=25^\circ\text{C}$	14		dB
		$I_C=30\text{mA}$; $V_{CE}=10\text{V}$; $f=2\text{GHz}$; $T_{amb}=25^\circ\text{C}$	8		dB
F	noise figure	$I_C=5\text{mA}$; $V_{CE}=10\text{V}$; $f=1\text{GHz}$; $s=opt$; $T_{amb}=25^\circ\text{C}$	2.1		dB
V_O	output voltage	$dim=60\text{dB}$; $I_C=14\text{mA}$; $V_{CE}=10\text{V}$; $R_L=75\Omega$; $T_{amb}=25^\circ\text{C}$; $f_p+f_{qfr}=793.25\text{MHz}$	150		mV

LIMITING VALUES

In accordance with the Absolute Maximum Rating System

SYMBOL	PARAMETER	CONDITIONS	MIN	MAX.	UNIT
V_{CBO}	collector-base voltage	open emitter	-	20	V
V_{CEO}	collector-emitter voltage	open base	-	15	V
V_{EBO}	emitter-base voltage	open collector	-	2	V

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I_C	collector current (DC)		-	25	mA
P_{tot}	total power dissipation	$T_s \leq 95^\circ\text{C}$; note 1	-	300	mW
T_{stg}	storage temperature		-65	+150	$^\circ\text{C}$
T_J	junction temperature		-	+175	$^\circ\text{C}$

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R_{Thj-s}	thermal resistance from junction to soldering point	$T_s \leq 95^\circ\text{C}$; note 1	260	mW

Note

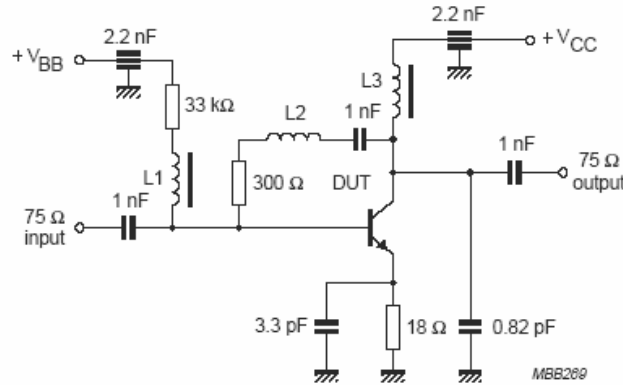
1. T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25^\circ\text{C}$ unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_{CBO}	Collector cut-off current	$I_E = 0$; $V_{CB} = 5\text{V}$	-	-	50	nA
h_{FE}	DC current gain	$I_C = 5\text{mA}$ $V_{CE} = 10\text{V}$	160	-	200	-
C_C	collector capacitance	$I_E = I_C = 0$; $V_{CB} = 10\text{V}$; $f = 1\text{MHz}$	-	0.6	-	pF
C_e	emitter capacitance	$I_C = I_E = 0$; $V_{EB} = 10\text{V}$; $f = 1\text{MHz}$	-	1.2	-	pF
C_{re}	feedback capacitance	$I_C = I_E = 0$; $V_{CE} = 10\text{V}$; $f = 1\text{MHz}$; $T_{amb} = 25^\circ\text{C}$	-	0.35	-	pF
f_T	transition frequency	$I_C = 15\text{mA}$; $V_{CE} = 5\text{V}$; $f = 500\text{MHz}$		5	-	GHz
G_{UM}	maximum unilateral power gain (note 1)	$I_C = 15\text{mA}$; $V_{CE} = 10\text{V}$; $f = 1\text{GHz}$; $T_{amb} = 25^\circ\text{C}$	-	14	-	dB
		$I_C = 15\text{mA}$; $V_{CE} = 10\text{V}$; $f = 2\text{GHz}$; $T_{amb} = 25^\circ\text{C}$	-	8	-	dB
F	noise figure	$I_C = 5\text{mA}$; $V_{CE} = 10\text{V}$; $f = 1\text{GHz}$; $s = \text{opt}$; $T_{amb} = 25^\circ\text{C}$	-	2.1	-	dB
		$I_C = 5\text{mA}$; $V_{CE} = 10\text{V}$; $f = 2\text{GHz}$; $s = \text{opt}$; $T_{amb} = 25^\circ\text{C}$	-	3	-	dB
V_O	output voltage		-	150	-	mV
d_2	second order intermodulation distortion		-	-50	-	dB

* pulse measurement $PW \leq 350 \mu\text{s}$, duty cycle $\leq 2\%$



L1 = L3 = 5 μ H choke.
 L2 = 3 turns 0.4 mm copper wire, internal diameter 3 mm, winding pitch 1 mm.

Fig.2 Intermodulation distortion and second harmonic distortion MATV test circuit.

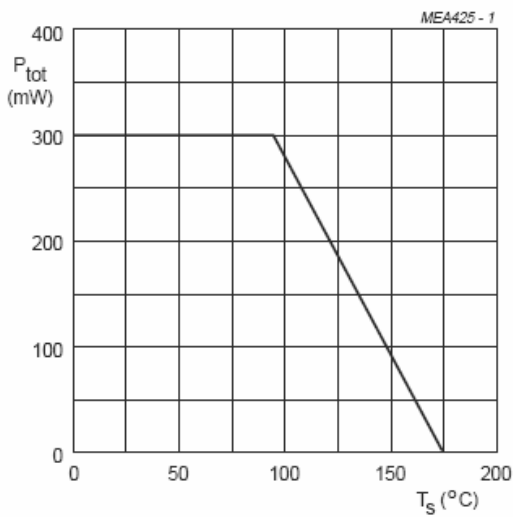
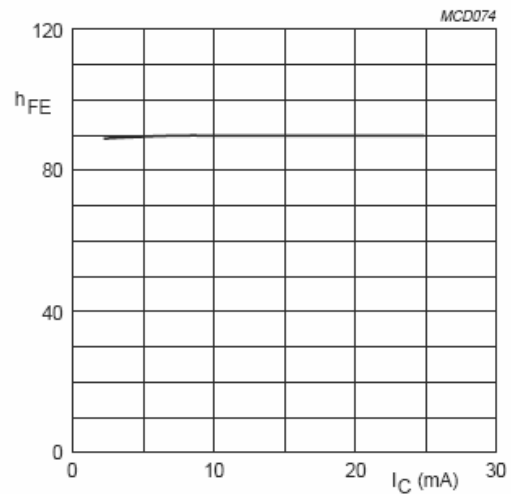


Fig.3 Power derating curve.

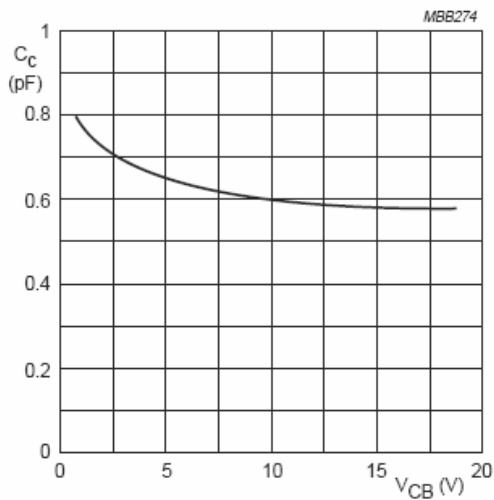


$V_{CE} = 10$ V; $T_j = 25$ °C.

Fig.4 DC current gain as a function of collector current; typical values.

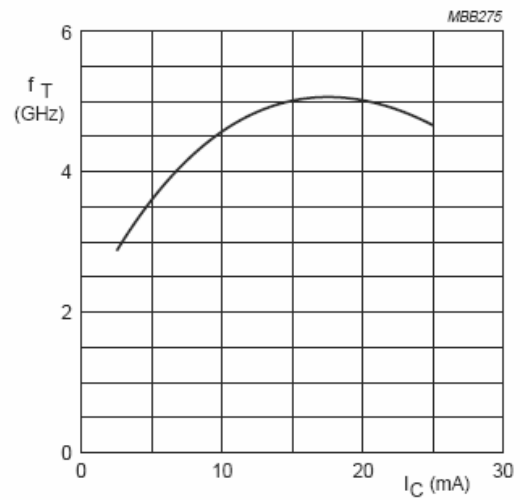
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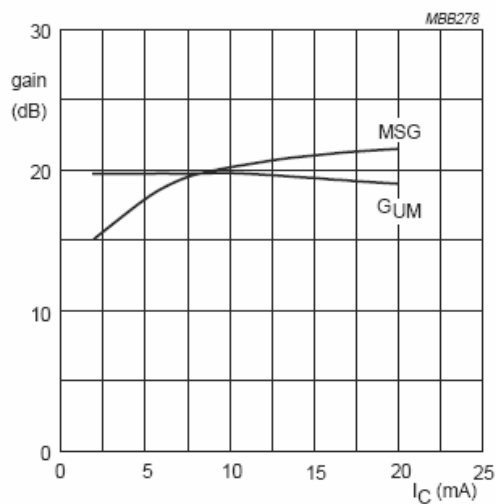
$I_C = I_E = 0$; $f = 1$ MHz; $T_j = 25$ °C.

Fig.5 Collector capacitance as a function of collector-base voltage; typical values.



$V_{CE} = 10$ V; $f = 500$ MHz; $T_{amb} = 25$ °C.

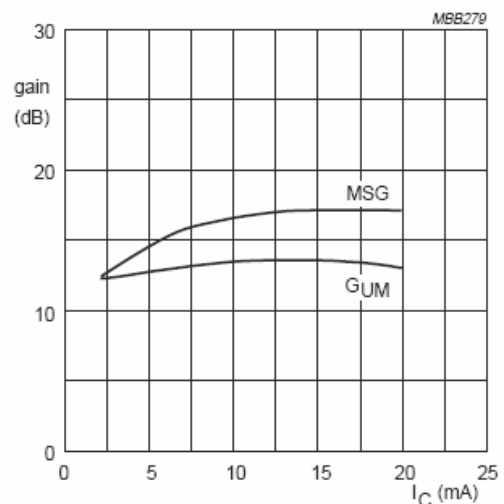
Fig.6 Transition frequency as a function of collector current; typical values.



$V_{CE} = 10$ V; $f = 500$ MHz.

MSG = maximum stable gain;
GUM = maximum unilateral power gain.

Fig.7 Gain as a function of collector current; typical values.



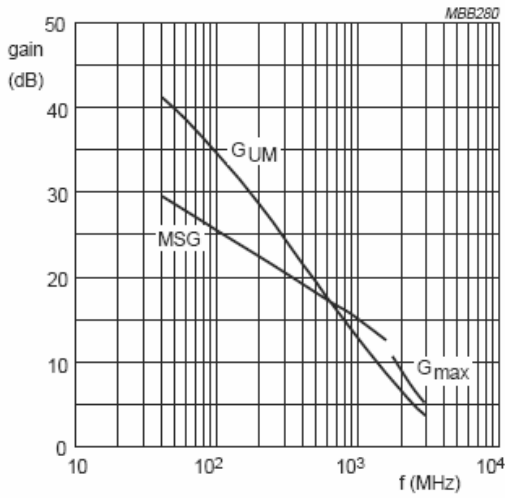
$V_{CE} = 10$ V; $f = 1$ GHz.

MSG = maximum stable gain;
GUM = maximum unilateral power gain.

Fig.8 Gain as a function of collector current; typical values.

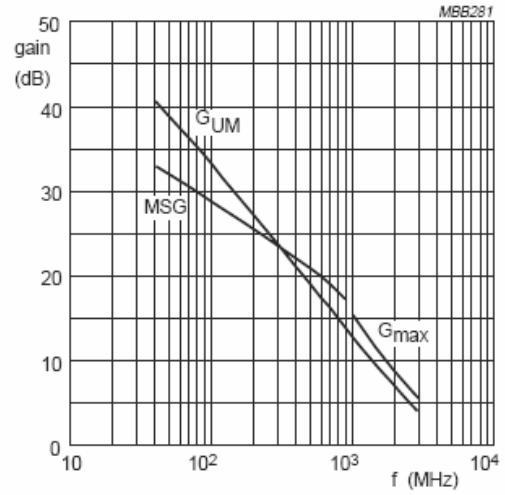
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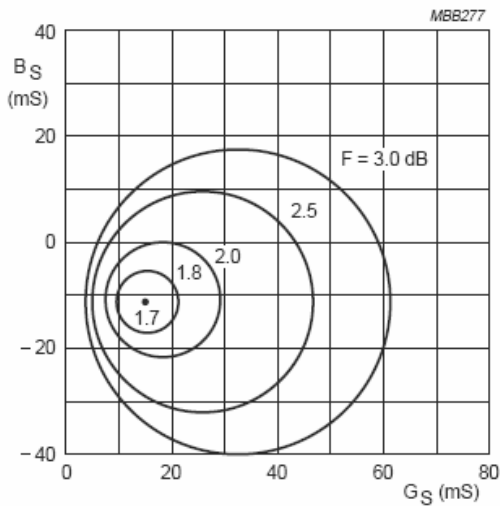
$I_C = 5 \text{ mA}$; $V_{CE} = 10 \text{ V}$.
 G_{UM} = maximum unilateral power gain; MSG = maximum stable gain;
 G_{max} = maximum available gain.

Fig.9 Gain as a function of frequency; typical values.



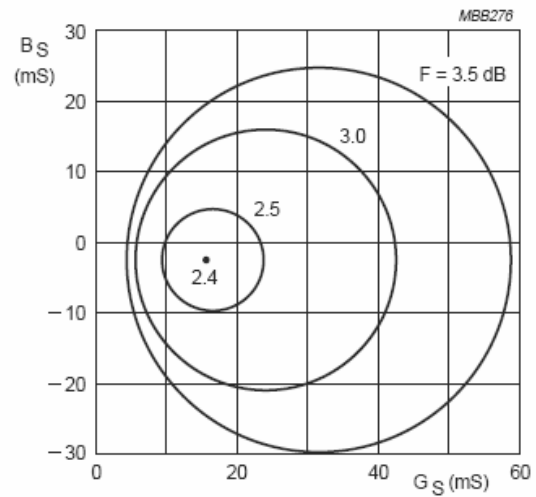
$I_C = 15 \text{ mA}$; $V_{CE} = 10 \text{ V}$.
 G_{UM} = maximum unilateral power gain; MSG = maximum stable gain;
 G_{max} = maximum available gain.

Fig.10 Gain as a function of frequency; typical values.



$I_C = 4 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $f = 800 \text{ MHz}$.

Fig.11 Circles of constant noise figure; typical values.

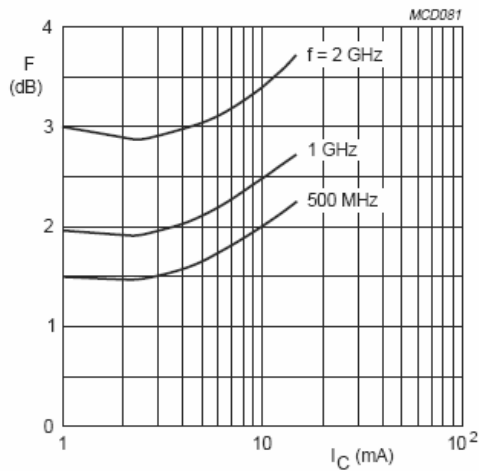


$I_C = 14 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $f = 800 \text{ MHz}$.

Fig.12 Circles of constant noise figure; typical values.

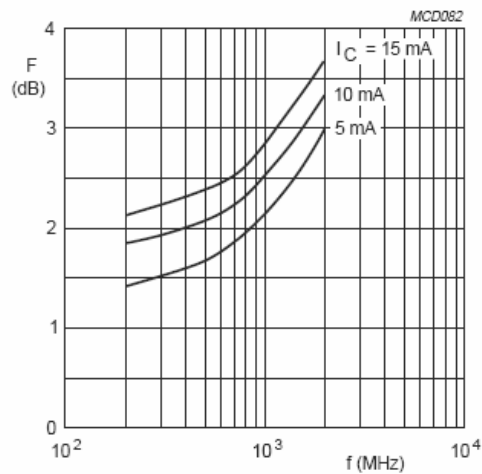
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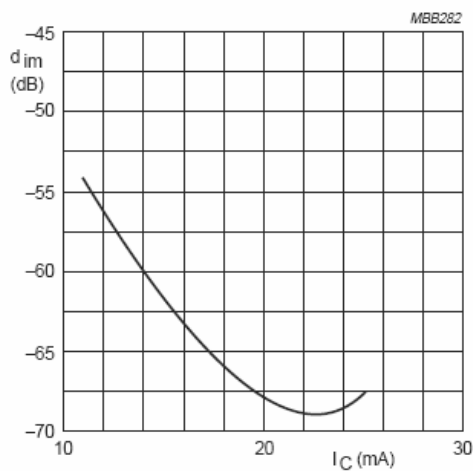
$V_{CE} = 10 \text{ V.}$

Fig.13 Minimum noise figure as a function of collector current; typical values.



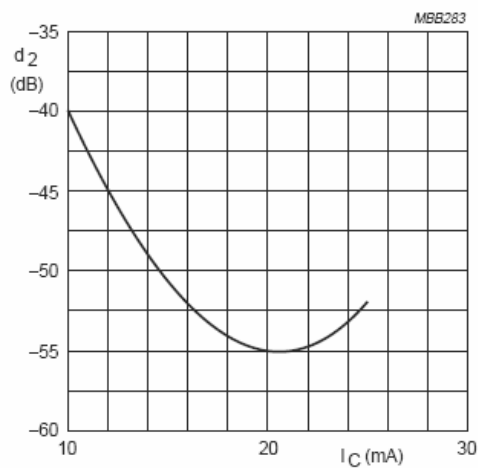
$V_{CE} = 10 \text{ V.}$

Fig.14 Minimum noise figure as a function of frequency; typical values.



$V_{CE} = 10 \text{ V; } V_O = 150 \text{ mV (43.5 dBmV);}$
 $f_p + f_q - f_r = 793.25 \text{ MHz; } T_{amb} = 25 \text{ }^\circ\text{C.}$
 Measured in MATV test circuit (see Fig.2).

Fig.15 Intermodulation distortion; typical values.



$V_{CE} = 10 \text{ V; } V_O = 60 \text{ mV; } f_p + f_q - f_r = 810 \text{ MHz; } T_{amb} = 25 \text{ }^\circ\text{C.}$
 Measured in MATV test circuit (see Fig.2).

Fig.16 Second order intermodulation distortion; typical values.

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